Sear	earch Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/616,647	HUANG ET AL.
Examiner	Art Unit
Benjamin P. Geib	2181

	SEARCHED		
Class	Subclass	Date	Examiner
712	216	6/17/2007	BPG
			-

INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

(INCLUDING SEAR	CH STRATEGY)
	DATE	EXMR
Updated EAST search	6/17/2007	BPG
Updated NPL search	6/17/2007	BPG
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